Supporting Information

In situ Synthesis of Bi₂O₃/Bi₂S₃ Composite Heterojunction for the

Electrochemical Characterization of Supercapacitors

1.Experimental Section

1.1 Electrochemical testing

The loads of the symmetrical and asymmetrical capacitors are calculated from Equation S1:

$$\frac{m^+}{m^-} = \frac{C^- \Delta V^-}{C^+ \Delta V^+} \#(s1)$$

where m+ and m- represent the mass of the positive and negative electrodes, respectively, C (F g-1)

is the specific capacitance, and ΔV (V) is the discharge voltage range.

2.DFT Calculation

2.1 Differential Charge Calculation

The density functional theory calculations were carried out by the Vienna Ab initio simulation packa ge (VASP)24, 25 based on the projected augmented wave (PAW) method, in which the exchange correlat ion energy is described by the functional of Perderw, Burke, and Ernzerhof (PBE) scheme26 including th e van der Waals (v dW) dispersion van der Waals corrections (DFT-D3 method)27. The cutoff energy of the planewave basis set was set at 500 eV. The convergence criterion was less than 10-5 eV in energy, 0.05 eV Å-1 in force. The Brillouin zone integrations were performed by using Monkhorst Pack 2×2×1 f or geometric optimization. To avoid periodic interactions, all models had a vacuum layer greater than 15 Å.

The band, density of states, figure of merit, and adsorption energy calculations were carried out usin g the CASTEP module of the MS2018 modeling and simulation package, and the Perdew Burke Ernzerh off (PBE) function from the Generalized Gradient Approximation (GGA) method was used to describe the exchange-correlation potential. The plane wave cutoff energy is 450 eV, and the Brillouin region is geom etrically optimized using a $2 \times 2 \times 1$ K point grid.SCF tolerance: $2.0 \times 10-6$ eV atom-1.

The adsorption energy is calculated as:

 $E_{ads} = E_{slab + molecule} - E_{slab} - E_{molecule} \# (s2)$

where Eads is the adsorption energy, E(slab+molecule) is the total energy after adsorption, and Eslab

and Emolecule represent the substrate energy and the energy of the adsorbed substance, respectively.



Fig. s1 (a-b) SEM images of BO; (c-d) SEM images of BS; (e-f) SEM images of BO/BS; (g) SEM images of BO-attached nickel foam; (h) SEM images of BS-attached nickel foam; (i) SEM images of BO/BS -attached nickel foam; (j) empty nickel foam SEM





Fig. S2 (a) SEM image of BO-attached nickel foam; (b) SEM image of BS-attached nickel foam; (c) SE M image of BO/BS-attached nickel foam; (d) SEM image of empty nickel foam; (e-g) EDS images of B O/BS



Fig. S3 (a) TEM image of BO/BS; (b-c) SAED images of BO/BS samples



Fig. S5 (a) CV curve of BO; (b) CV curve of BS; (c) CV curve of BO/BS;(d) GCD curves of BO; (e) GCD curves of BS; (f) GCD curves of BO/BS;



Fig. S6 (a) CV curves of BS at 0-0.8 V; (b) Integral areas of BO, BS, and BO/BS with respect to CV; (c) Porter phase angles of BO, BS, and BO/BS; (d) Ragone plot



Fig. S7 Diffusion control occupancy at 50 mV s-1 sweep rate (a) CV curve of BO; (b) CV curve of BS; (c) CV curve of BO/BS



Fig. S8 Electrochemical performance of the physically mixed BO and BS sample, (a) Cyclic Voltammetry (CV) and (b) Galvanostatic Charge-Discharge (GCD) curves.



Fig. S9 (a) Top view of the Bi2O3 model; (b) Top view of the Bi₂S₃ model; (c) Top view of the Bi₂O₃ /Bi₂S₃ model; (d) Model of the Bi₂O₃(2 0 0)¹ facet; (e) Model of the Bi₂S₃(1 3 0)¹ facet; ;(f) Model of the Bi₂O₃/Bi₂S₃ heterojunction after faceting



Fig. S10 (a) DOS plot of Bi_2O_3 ; (b) DOS plot of Bi2S3; (c) DOS plot of Bi_2O_3 / Bi_2S_3 ; (d) Work functi on calculation of Bi_2O_3 ; (b) Work function calculation of Bi_2S_3

Sample	SBET	Pore volume	volume Average pore size (n		lingen fasten
	(m ² g ⁻¹)	(cm3 g ⁻¹)	m)	C value	linear factor
BO	0.4040	0.00025	2.42766	32.72859	0.99812
BO/BS	1.7360	0.00094	2.16106	12.72628	0.99989

Tab.S1: BET testing of BO, BO/BS

The lattice parameters	BO	BS	BO/BS
a (Å)	10.08906	4.387	7.2688
b (Å)	10.08906	11.147	8.639
c (Å)	10.08906	11.305	11.9698
effective lattice constant	√305.364	√271.188	√270.882
α (°)	90	90	87.713
β (°)	90	90	93.227
γ (°)	90	90	86.653

Tab.S2: Lattice parameters of BO, BS, BO/BS

Scanning speed rate (m V s ⁻¹)	SBO	SBS	SBO/BS
5	0.497	1.378	1.604
10	0.816	1.537	2.618
20	1.373	1.674	4.224
30	1.833	1.733	5.432
40	2.239	1.745	6.351
50	2.598	1.730	7.001

Tab.S3: Integral area of BO, BS, BO/BS with respect to CV

Sample (A g ⁻¹)	2	4	6	8	10
BO	62.0	54.5	50.6	47.1	47.8
BS	294.8	235.4	194.5	161.6	154.4
BO/BS	305.6	246.2	221.8	213.0	202.8

Tab.S4: Specific capacitance of BO, BS, BO/BS at different capacitance densities

Scanning speed rate (m $V s^{-1}$)	ВО	BS	BO/BS
5	12.72%	7.78%	9.67%
10	16.14%	11.86%	12.16%
20	20.84%	20.00%	16.44%
30	24.93%	29.17%	19.45%
40	28.22%	37.84%	22.60%

Tab.S5: Surface control ratios of BO, BS, and BO/BS at different sweep speeds

Scanning speed rate (m V s ⁻¹)	ВО	BS	BO/BS
5	87.28%	92.22%	90.33%
10	83.86%	88.14%	87.84%
20	79.16%	80.00%	83.56%
30	75.07%	70.83%	80.55%
40	71.78%	62.16%	77.40%
50	68.87%	54.55%	75.25%

Tab.S6: Diffusion control ratios of BO, BS, and BO/BS at different sweep speeds

	BO	BS	BO/BS
Rs	0.8205	0.77429	0.78511
Rct	9.168	1.417	0.023808
CPE1-T	0.023284	0.032391	0.0029713
CPE1-P	0.72358	0.89192	1.215
Wo-R	1.156	17.17	1.741
Wo-T	0.035505	7.953	50594
Wo-P	0.36607	0.45658	0.36788

Tab.S7: Fitted circuit parameters for BO, BS, BO/BS

materials of the heterojunction	adsorbed species	adsorption energy (eV)
carbon ²	SBP^+	-3.36
MoS_2 in-planes ³	$\mathrm{NH_4^+}$	-2.49
P-doped NiO ⁴	OH-	0.64
NiCo ₂ S ₄ ⁵	OH-	-3.0654
CuCo-LDH/BPQD ⁶	OH-	0.375
This work	OH-	-7.66

Tab.S8: Comparison of Adsorption Energies

Sample	Potential window	Electrolyte	Specific cap acitance	Stability
Bi_2S_3/MWC^2	-0.6~0V	0.5 M Na ₂ SO ₄	133 F g ⁻¹ (1 A g ⁻¹)	80 %(3000 cycles,10 A g ⁻¹)

Bi ₂ O ₃ /porous-RGO ⁸	-1.2-0.2V	6 М КОН	243 F g ⁻¹ (5 mV s ⁻¹)	81.1 %(3000cycle,0.5 A g ⁻¹)
PEDOP/Bi ₂ S ₃ ⁹	-0.2-0.8 V	organic elec trolyte	201 F g ⁻¹ (1 A g ⁻¹)	94 %(1000 cycle,1 A g -1)
Bi ₂ Se ₃ @C ¹⁰	-1.1-0V	6 М КОН	540 C g ⁻¹ (2 A g ⁻¹)	90.5 %(1000 cycle,1 A g ⁻¹)
$Ag/Bi_2O_3/g\text{-}C_3N_4{}^{\underline{6}}$	0.2-0.6V	КОН	100.5 Fg ⁻¹ (2 A g ⁻¹)	
Flowerlike Bi ₂ MoO ₆ Hollow Microspheres <u>11</u>	0-0.6V	3 М КОН	182 Fg ⁻¹ (1 A g ⁻¹)	80 %(3000 cycle,5 A g ⁻¹)
$Bi_{25}FeO_{40}$ +7 wt %P VP $\frac{12}{}$	-1-0V	6 М КОН	232 F g ⁻¹ (4 A g ⁻¹)	84 %(1000 cycle,5 A g -1)
$Bi_2S_3/FGS^{\underline{13}}$	-0.9-0V	1 M Na ₂ S O ₄	292 F g ⁻¹ (1 A g ⁻¹)	75 %(5000 cycle,5 A g -1)
$MoS_2/Bi_2S_3^{\underline{14}}$	-0.2-0.8V	1 М КОН	120 Fg ⁻¹ (1 A g ⁻¹)	87.7 %(2000 cycle,1 A g ⁻¹)
Bi_2S_3 /graphene ¹³	-0.9-0V	1 M Na ₂ S O ₄	292 F g ⁻¹ (1 A g ⁻¹)	75 %(5000 cycle,5 A g ⁻¹)
BiFeO ₃ ¹⁵	0-0.45V	3 М КОН	253 F g ⁻¹ (1 A g ⁻¹)	88 %(5000 cycle,10 A g ⁻¹)
Bi ₂ WO ₆ /rGO HGs <u>¹⁶</u>			268.7 F g ⁻¹ (0.75 A g ⁻¹)	81 %(1000 cycle,3 A g -1)
Bi+Fe ₃ O ₄ <u>17</u>	-1-0V	1 M Na ₂ S O ₃	235 F g ⁻¹ (0. 2 A g ⁻¹)	72.5 %(5000 cycle,2 A g ⁻¹)

$CdS@Bi_2Se_3^{\underline{18}}$	-0.8-0V	1 M NaCl	198 F g ⁻¹ (1 mAh cm ⁻¹)	80 %(2000 cycle,2 A g ⁻¹)
AC-Bi ₂ O ₃ ¹⁹	-1-0V	6 М КОН	252.9 F g ⁻¹ (20 mVs ⁻¹)	59 %(1000 cycle)
This work	0-0.6V	6 М КОН	305.57 F g ⁻¹ (2 A g ⁻¹)	94.12 %(1000 cycle,10 A g ⁻¹)

Tab.S9: Performance Comparison Chart

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